

<b>Notice of References Cited</b>	Application/Control No. 09/864,524	Applicant(s)/Patent Under Reexamination LAKSONO, INDRA	
	Examiner Sargon N. Nano	Art Unit 2157	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,567,981	05-2003	Jeffrey, Ross A.	725/80
*	B	US-5,751,282	05-1998	Girard et al.	715/721
*	C	US-6,023,731	02-2000	Chawla, Rajeev	709/231
*	D	US-6,157,673	12-2000	Cuccia, David W.	375/240
*	E	US-5,818,511	10-1998	Farry et al.	725/116
*	F	US-5,745,846	04-1998	Myer et al.	455/209
*	G	US-6,747,998	06-2004	Enari, Masahiko	370/516
*	H	US-6,178,446	01-2001	Gerszberg et al.	709/217
*	I	US-5,917,781	06-1999	Kim, Young Chul	369/4
*	J	US-5,751,282	05-1998	Girard et al.	715/721
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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